AMD Xilinx - XC2S100-6FG256C Datasheet

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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Active
Number of LABs/CLBs	600
Number of Logic Elements/Cells	2700
Total RAM Bits	40960
Number of I/O	176
Number of Gates	100000
Voltage - Supply	2.375V ~ 2.625V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	256-BGA
Supplier Device Package	256-FBGA (17x17)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc2s100-6fg256c

Spartan-II Product Availability

Table 2 shows the maximum user I/Os available on the device and the number of user I/Os available for each device/package combination. The four global clock pins are usable as additional user I/Os when not used as a global clock pin. These pins are not included in user I/O counts.

Table 2: **Spartan-II FPGA User I/O Chart(1)**

Device	Maximum User I/O	Available User I/O According to Package Type					
		VQ100 VQG100	TQ144 TQG144	CS144 CSG144	PQ208 PQG208	FG256 FGG256	FG456 FGG456
XC2S15	86	60	86	(Note 2)	-	-	-
XC2S30	92	60	92	92	(Note 2)	-	-
XC2S50	176	-	92	-	140	176	-
XC2S100	176	-	92	-	140	176	(Note 2)
XC2S150	260	-	-	-	140	176	260
XC2S200	284	-	-	-	140	176	284

Notes:
1. All user I/O counts do not include the four global clock/user input pins.
2. Discontinued by PDN2004-01.

Architectural Description

Spartan-II FPGA Array

The Spartan®-II field-programmable gate array, shown in Figure 2, is composed of five major configurable elements:

- IOBs provide the interface between the package pins and the internal logic
- CLBs provide the functional elements for constructing most logic
- Dedicated block RAM memories of 4096 bits each
- Clock DLLs for clock-distribution delay compensation and clock domain control
- Versatile multi-level interconnect structure

As can be seen in Figure 2, the CLBs form the central logic structure with easy access to all support and routing structures. The IOBs are located around all the logic and memory elements for easy and quick routing of signals on and off the chip.

Values stored in static memory cells control all the configurable logic elements and interconnect resources. These values load into the memory cells on power-up, and can reload if necessary to change the function of the device.

Each of these elements will be discussed in detail in the following sections.

Input/Output Block

The Spartan-II FPGA IOB, as seen in Figure 2, features inputs and outputs that support a wide variety of I/O signaling standards. These high-speed inputs and outputs are capable of supporting various state of the art memory and bus interfaces. Table 3 lists several of the standards which are supported along with the required reference, output and termination voltages needed to meet the standard.

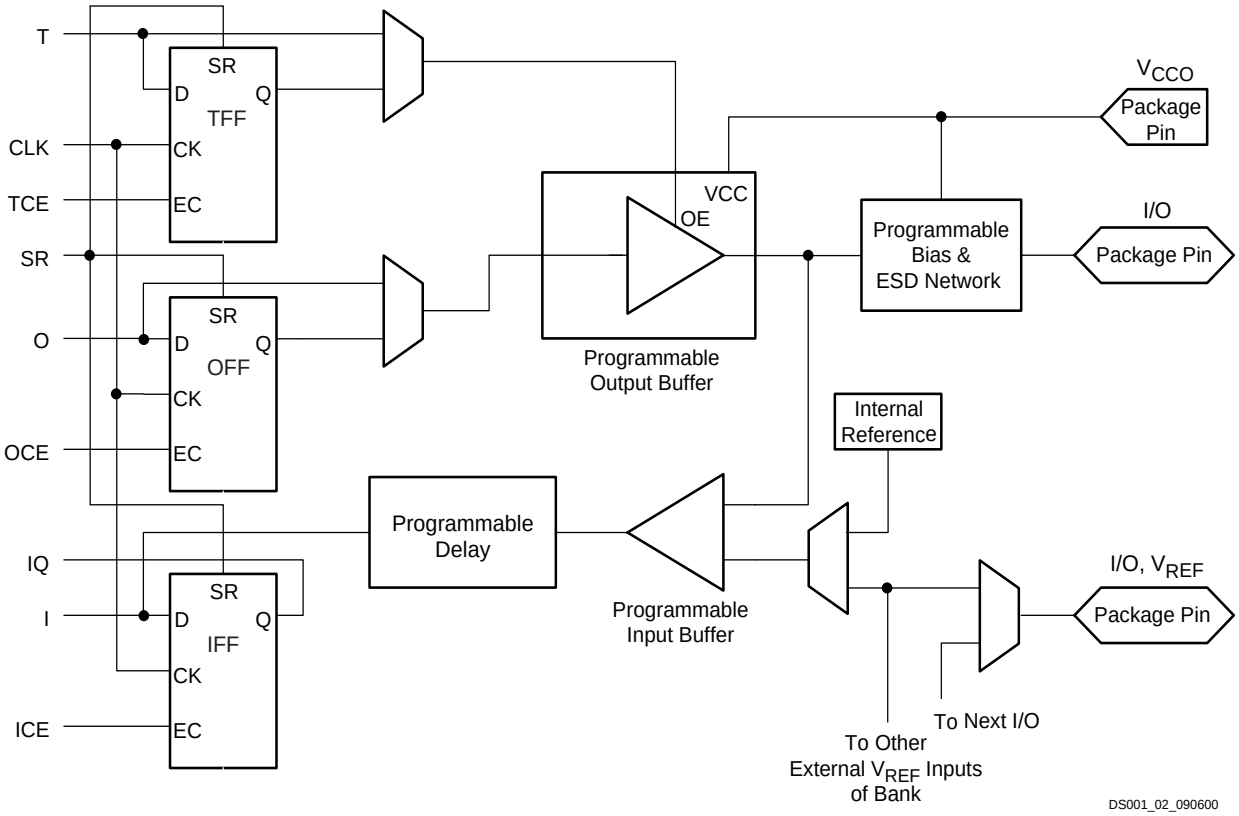


Figure 2: **Spartan-II FPGA Input/Output Block (IOB)**

Local Routing

The local routing resources, as shown in Figure 6, provide the following three types of connections:

- Interconnections among the LUTs, flip-flops, and General Routing Matrix (GRM)
- Internal CLB feedback paths that provide high-speed connections to LUTs within the same CLB, chaining them together with minimal routing delay
- Direct paths that provide high-speed connections between horizontally adjacent CLBs, eliminating the delay of the GRM

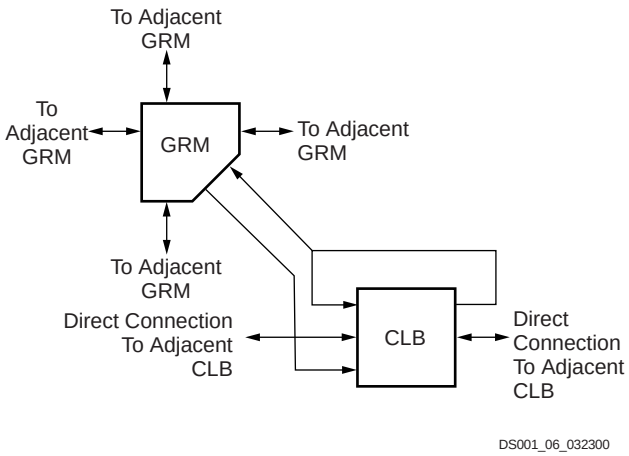


Figure 6: **Spartan-II Local Routing**

General Purpose Routing

Most Spartan-II FPGA signals are routed on the general purpose routing, and consequently, the majority of interconnect resources are associated with this level of the routing hierarchy. The general routing resources are located in horizontal and vertical routing channels associated with the rows and columns CLBs. The general-purpose routing resources are listed below.

- Adjacent to each CLB is a General Routing Matrix (GRM). The GRM is the switch matrix through which horizontal and vertical routing resources connect, and is also the means by which the CLB gains access to the general purpose routing.
- 24 single-length lines route GRM signals to adjacent GRMs in each of the four directions.
- 96 buffered Hex lines route GRM signals to other GRMs six blocks away in each one of the four directions. Organized in a staggered pattern, Hex lines may be driven only at their endpoints. Hex-line signals can be accessed either at the endpoints or at the midpoint (three blocks from the source). One third of the Hex lines are bidirectional, while the remaining ones are unidirectional.
- 12 Longlines are buffered, bidirectional wires that distribute signals across the device quickly and efficiently. Vertical Longlines span the full height of the device, and horizontal ones span the full width of the device.

I/O Routing

Spartan-II devices have additional routing resources around their periphery that form an interface between the CLB array and the IOBs. This additional routing, called the VersaRing, facilitates pin-swapping and pin-locking, such that logic redesigns can adapt to existing PCB layouts. Time-to-market is reduced, since PCBs and other system components can be manufactured while the logic design is still in progress.

Dedicated Routing

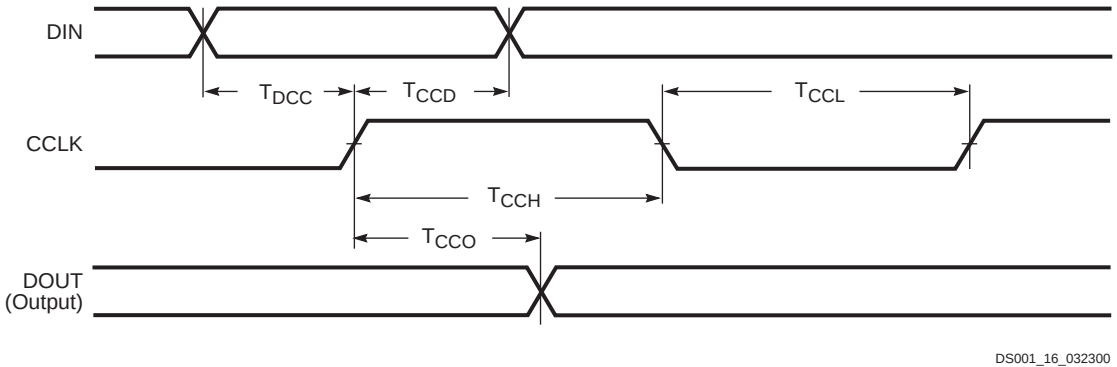
Some classes of signal require dedicated routing resources to maximize performance. In the Spartan-II architecture, dedicated routing resources are provided for two classes of signal.

- Horizontal routing resources are provided for on-chip 3-state busses. Four partitionable bus lines are provided per CLB row, permitting multiple busses within a row, as shown in Figure 7.
- Two dedicated nets per CLB propagate carry signals vertically to the adjacent CLB.

Global Routing

Global Routing resources distribute clocks and other signals with very high fanout throughout the device. Spartan-II devices include two tiers of global routing resources referred to as primary and secondary global routing resources.

- The primary global routing resources are four dedicated global nets with dedicated input pins that are designed to distribute high-fanout clock signals with minimal skew. Each global clock net can drive all CLB, IOB, and block RAM clock pins. The primary global nets may only be driven by global buffers. There are four global buffers, one for each global net.
- The secondary global routing resources consist of 24 backbone lines, 12 across the top of the chip and 12 across bottom. From these lines, up to 12 unique signals per column can be distributed via the 12 longlines in the column. These secondary resources are more flexible than the primary resources since they are not restricted to routing only to clock pins.



Symbol		Description		Units
T_{DCC}	CCLK	DIN setup	5	ns, min
T_{CCD}		DIN hold	0	ns, min
T_{CCO}		DOUT	12	ns, max
T_{CCH}		High time	5	ns, min
T_{CCL}		Low time	5	ns, min
F_{CC}		Maximum frequency	66	MHz, max

Figure 16: **Slave Serial Mode Timing**

If CCLK is slower than F_{CCNH}, the FPGA will never assert BUSY. In this case, the above handshake is unnecessary, and data can simply be entered into the FPGA every CCLK cycle.

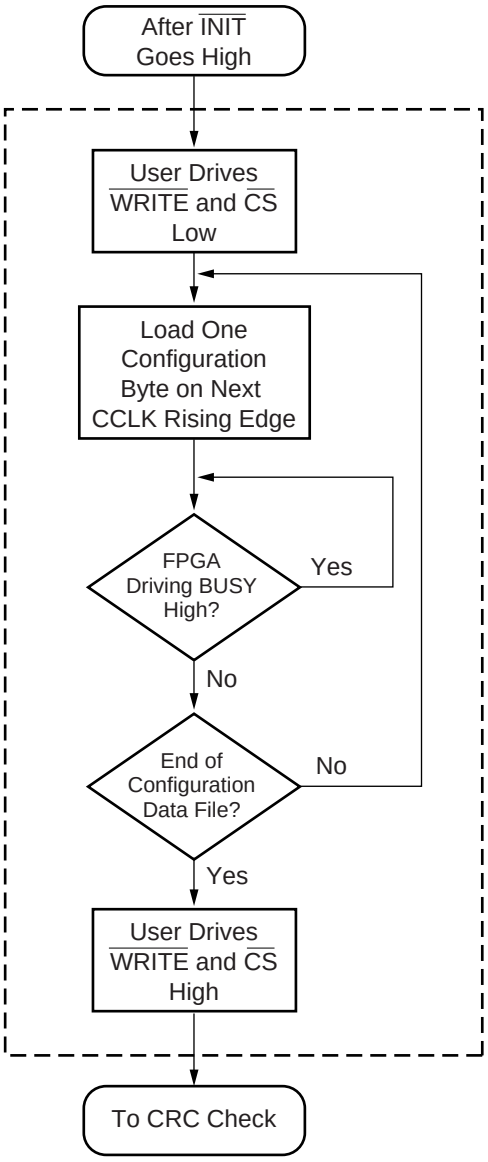


Figure 19: **Loading Configuration Data for the Slave Parallel Mode**

A configuration packet does not have to be written in one continuous stretch, rather it can be split into many write sequences. Each sequence would involve assertion of $\overline{CS}$.

In applications where multiple clock cycles may be required to access the configuration data before each byte can be loaded into the Slave Parallel interface, a new byte of data may not be ready for each consecutive CCLK edge. In such a case the $\overline{CS}$ signal may be de-asserted until the next byte is valid on D0-D7. While $\overline{CS}$ is High, the Slave Parallel interface does not expect any data and ignores all CCLK transitions. However, to avoid aborting configuration, $\overline{WRITE}$ must continue to be asserted while $\overline{CS}$ is asserted.

Abort

To abort configuration during a write sequence, de-assert $\overline{WRITE}$ while holding $\overline{CS}$ Low. The abort operation is initiated at the rising edge of CCLK, as shown in Figure 21, page 26. The device will remain BUSY until the aborted operation is complete. After aborting configuration, data is assumed to be unaligned to word boundaries and the FPGA requires a new synchronization word prior to accepting any new packets.

Boundary-Scan Mode

In the boundary-scan mode, no nondedicated pins are required, configuration being done entirely through the IEEE 1149.1 Test Access Port.

Configuration through the TAP uses the special CFG_IN instruction. This instruction allows data input on TDI to be converted into data packets for the internal configuration bus.

The following steps are required to configure the FPGA through the boundary-scan port.

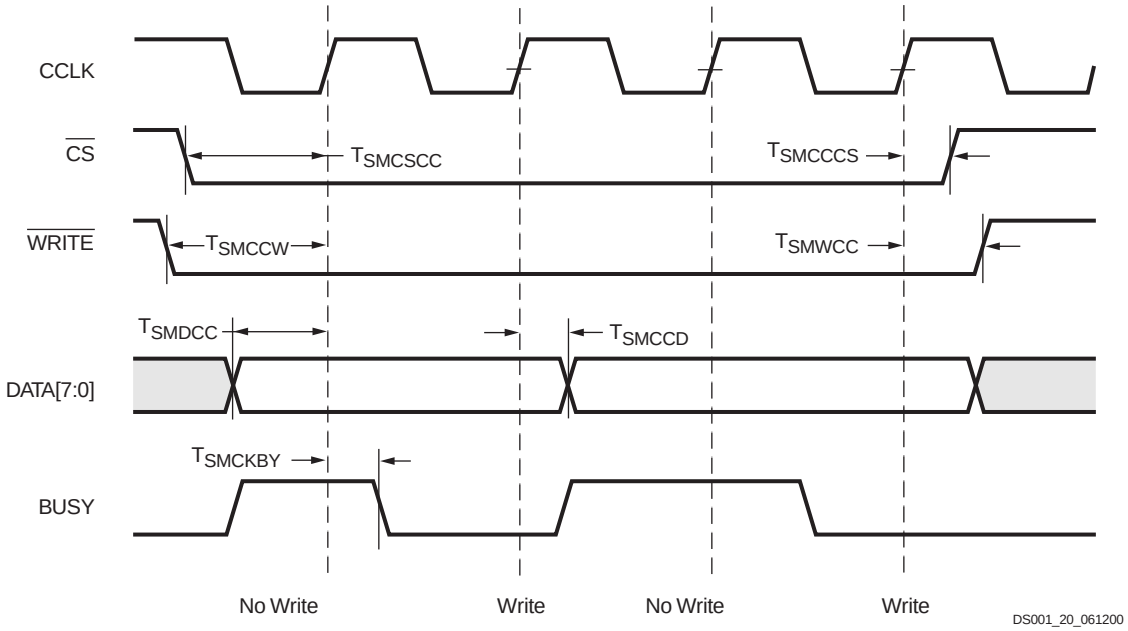
1. Load the CFG_IN instruction into the boundary-scan instruction register (IR)
2. Enter the Shift-DR (SDR) state
3. Shift a standard configuration bitstream into TDI
4. Return to Run-Test-Idle (RTI)
5. Load the JSTART instruction into IR
6. Enter the SDR state
7. Clock TCK through the sequence (the length is programmable)
8. Return to RTI

Configuration and readback via the TAP is always available. The boundary-scan mode simply locks out the other modes. The boundary-scan mode is selected by a <10x> on the mode pins (M0, M1, M2).

Readback

The configuration data stored in the Spartan-II FPGA configuration memory can be readback for verification. Along with the configuration data it is possible to readback the contents of all flip-flops/latches, LUT RAMs, and block RAMs. This capability is used for real-time debugging.

For more detailed information see XAPP176, *Spartan-II FPGA Family Configuration and Readback.*



Symbol		Description		Units
T_{SMDCC}	CCLK	D0-D7 setup/hold	5	ns, min
T_{SMCCD}		D0-D7 hold	0	ns, min
T_{SMCSCC}		$\overline{CS}$ setup	7	ns, min
T_{SMCCCS}		$\overline{CS}$ hold	0	ns, min
T_{SMCCW}		$\overline{WRITE}$ setup	7	ns, min
T_{SMWCC}		$\overline{WRITE}$ hold	0	ns, min
T_{SMCKBY}		BUSY propagation delay	12	ns, max
F_{CC}		Maximum frequency	66	MHz, max
F_{CCNH}		Maximum frequency with no handshake	50	MHz, max

Figure 20: **Slave Parallel Write Timing**

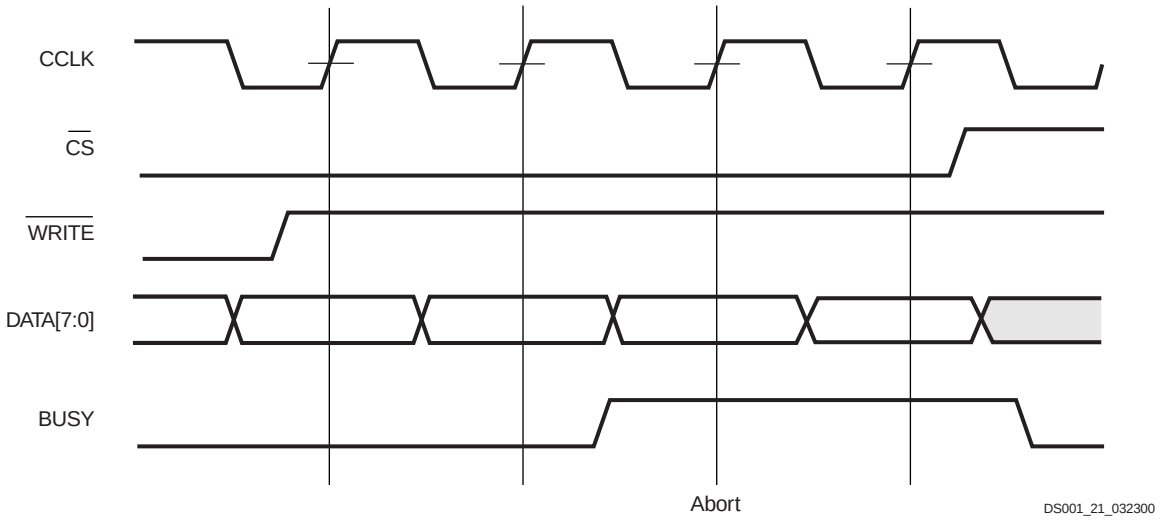


Figure 21: **Slave Parallel Write Abort Waveforms**

PCI — Peripheral Component Interface

The Peripheral Component Interface (PCI) standard specifies support for both 33 MHz and 66 MHz PCI bus applications. It uses a LVTTL input buffer and a push-pull output buffer. This standard does not require the use of a reference voltage (V_{REF}) or a board termination voltage (V_{TT}), however, it does require a 3.3V output source voltage (V_{CCO}). I/Os configured for the PCI, 33 MHz, 5V standard are also 5V-tolerant.

GTL — Gunning Transceiver Logic Terminated

The Gunning Transceiver Logic (GTL) standard is a high-speed bus standard (JESD8.3). Xilinx has implemented the terminated variation of this standard. This standard requires a differential amplifier input buffer and an open-drain output buffer.

GTL+ — Gunning Transceiver Logic Plus

The Gunning Transceiver Logic Plus (GTL+) standard is a high-speed bus standard (JESD8.3).

HSTL — High-Speed Transceiver Logic

The High-Speed Transceiver Logic (HSTL) standard is a general purpose high-speed, 1.5V bus standard (EIA/JESD 8-6). This standard has four variations or classes. Versatile I/O devices support Class I, III, and IV. This standard requires a Differential Amplifier input buffer and a Push-Pull output buffer.

SSTL3 — Stub Series Terminated Logic for 3.3V

The Stub Series Terminated Logic for 3.3V (SSTL3) standard is a general purpose 3.3V memory bus standard (JESD8-8). This standard has two classes, I and II. Versatile I/O devices support both classes for the SSTL3 standard. This standard requires a Differential Amplifier input buffer and an Push-Pull output buffer.

SSTL2 — Stub Series Terminated Logic for 2.5V

The Stub Series Terminated Logic for 2.5V (SSTL2) standard is a general purpose 2.5V memory bus standard (JESD8-9). This standard has two classes, I and II. Versatile I/O devices support both classes for the SSTL2 standard. This standard requires a Differential Amplifier input buffer and an Push-Pull output buffer.

CTT — Center Tap Terminated

The Center Tap Terminated (CTT) standard is a 3.3V memory bus standard (JESD8-4). This standard requires a Differential Amplifier input buffer and a Push-Pull output buffer.

AGP-2X — Advanced Graphics Port

The AGP standard is a 3.3V Advanced Graphics Port-2X bus standard used with processors for graphics applications. This standard requires a Push-Pull output buffer and a Differential Amplifier input buffer.

Library Primitives

The Xilinx library includes an extensive list of primitives designed to provide support for the variety of Versatile I/O features. Most of these primitives represent variations of the five generic Versatile I/O primitives:

- IBUF (input buffer)
- IBUFG (global clock input buffer)
- OBUF (output buffer)
- OBUFT (3-state output buffer)
- IOBUF (input/output buffer)

These primitives are available with various extensions to define the desired I/O standard. However, it is recommended that customers use a a property or attribute on the generic primitive to specify the I/O standard. See "Versatile I/O Properties".

IBUF

Signals used as inputs to the Spartan-II device must source an input buffer (IBUF) via an external input port. The generic IBUF primitive appears in Figure 35. The assumed standard is LVTTL when the generic IBUF has no specified extension or property.

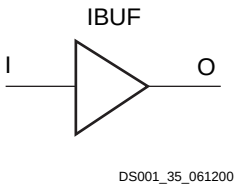


Figure 35: **Input Buffer (IBUF) Primitive**

When the IBUF primitive supports an I/O standard such as LVTTL, LVCMOS, or PCI33_5, the IBUF automatically configures as a 5V tolerant input buffer unless the V_{CCO} for the bank is less than 2V. If the single-ended IBUF is placed in a bank with an HSTL standard (V_{CCO} < 2V), the input buffer is not 5V tolerant.

The voltage reference signal is "banked" within the Spartan-II device on a half-edge basis such that for all packages there are eight independent V_{REF} banks internally. See Figure 36 for a representation of the I/O banks. Within each bank approximately one of every six I/O pins is automatically configured as a V_{REF} input.

IBUF placement restrictions require that any differential amplifier input signals within a bank be of the same standard. How to specify a specific location for the IBUF via

HSTL Class III

A sample circuit illustrating a valid termination technique for HSTL_III appears in Figure 45. DC voltage specifications appear in Table 23 for the HSTL_III standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

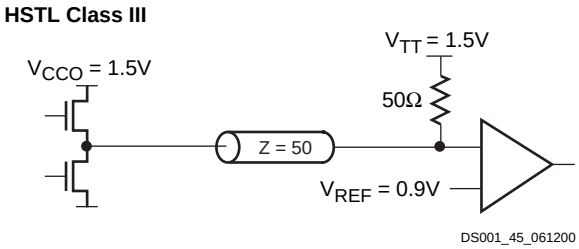


Figure 45: **Terminated HSTL Class III**

Table 23: **HSTL Class III Voltage Specification**

Parameter	Min	Typ	Max
V_{CCO}	1.40	1.50	1.60
V_{REF} (1)	-	0.90	-
V_{TT}	-	V_{CCO}	-
V_{IH}	V_{REF} + 0.1	-	-
V_{IL}	-	-	V_{REF} – 0.1
V_{OH}	V_{CCO} – 0.4	-	-
V_{OL}	-	-	0.4
I_{OH} at V_{OH} (mA)	–8	-	-
I_{OL} at V_{OL} (mA)	24	-	-

Notes:

1. Per EIA/JESD8-6, "The value of V_{REF} is to be selected by the user to provide optimum noise margin in the use conditions specified by the user."

HSTL Class IV

A sample circuit illustrating a valid termination technique for HSTL_IV appears in Figure 46.DC voltage specifications appear in Table 23 for the HSTL_IV standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics

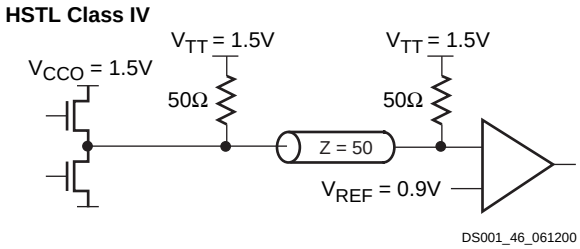


Figure 46: **Terminated HSTL Class IV**

Table 24: **HSTL Class IV Voltage Specification**

Parameter	Min	Typ	Max
V_{CCO}	1.40	1.50	1.60
V_{REF}	-	0.90	-
V_{TT}	-	V_{CCO}	-
V_{IH}	V_{REF} + 0.1	-	-
V_{IL}	-	-	V_{REF} – 0.1
V_{OH}	V_{CCO} – 0.4	-	-
V_{OL}	-	-	0.4
I_{OH} at V_{OH} (mA)	–8	-	-
I_{OL} at V_{OL} (mA)	48	-	-

Notes:

1. Per EIA/JESD8-6, "The value of V_{REF} is to be selected by the user to provide optimum noise margin in the use conditions specified by the user."

SSTL3 Class I

A sample circuit illustrating a valid termination technique for SSTL3_I appears in Figure 47. DC voltage specifications appear in Table 25 for the SSTL3_I standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

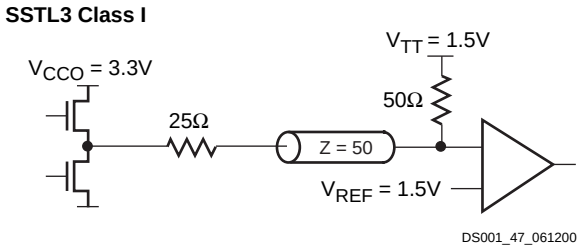


Figure 47: **Terminated SSTL3 Class I**

Table 25: **SSTL3_I Voltage Specifications**

Parameter	Min	Typ	Max
V_{CCO}	3.0	3.3	3.6
$V_{REF} = 0.45 \times V_{CCO}$	1.3	1.5	1.7
$V_{TT} = V_{REF}$	1.3	1.5	1.7
$V_{IH} \geq V_{REF} + 0.2$	1.5	1.7	3.9(1)
$V_{IL} \leq V_{REF} - 0.2$	–0.3(2)	1.3	1.5
$V_{OH} \geq V_{REF} + 0.6$	1.9	-	-
$V_{OL} \leq V_{REF} - 0.6$	-	-	1.1
I_{OH} at V_{OH} (mA)	–8	-	-
I_{OL} at V_{OL} (mA)	8	-	-

Notes:
1. V_{IH} maximum is V_{CCO} + 0.3.
2. V_{IL} minimum does not conform to the formula.

SSTL3 Class II

A sample circuit illustrating a valid termination technique for SSTL3_II appears in Figure 48. DC voltage specifications appear in Table 26 for the SSTL3_II standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

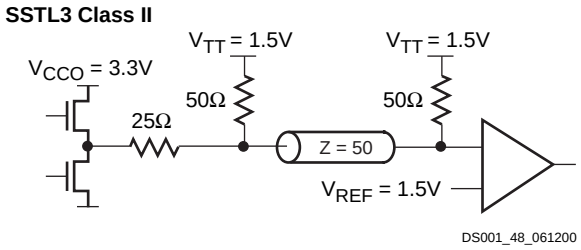


Figure 48: **Terminated SSTL3 Class II**

Table 26: **SSTL3_II Voltage Specifications**

Parameter	Min	Typ	Max
V_{CCO}	3.0	3.3	3.6
$V_{REF} = 0.45 \times V_{CCO}$	1.3	1.5	1.7
$V_{TT} = V_{REF}$	1.3	1.5	1.7
$V_{IH} \geq V_{REF} + 0.2$	1.5	1.7	3.9(1)
$V_{IL} \leq V_{REF} - 0.2$	–0.3(2)	1.3	1.5
$V_{OH} \geq V_{REF} + 0.8$	2.1	-	-
$V_{OL} \leq V_{REF} - 0.8$	-	-	0.9
I_{OH} at V_{OH} (mA)	–16	-	-
I_{OL} at V_{OL} (mA)	16	-	-

Notes:
1. V_{IH} maximum is V_{CCO} + 0.3
2. V_{IL} minimum does not conform to the formula

LVTTL

LVTTL requires no termination. DC voltage specifications appears in Table 32 for the LVTTL standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

Table 32: **LVTTL Voltage Specifications**

Parameter	Min	Typ	Max
V_{CCO}	3.0	3.3	3.6
V_{REF}	-	-	-
V_{TT}	-	-	-
V_{IH}	2.0	-	5.5
V_{IL}	–0.5	-	0.8
V_{OH}	2.4	-	-
V_{OL}	-	-	0.4
I_{OH} at V_{OH} (mA)	–24	-	-
I_{OL} at V_{OL} (mA)	24	-	-

Notes:
1. V_{OL} and V_{OH} for lower drive currents sample tested.

LVCMOS2

LVCMOS2 requires no termination. DC voltage specifications appear in Table 33 for the LVCMOS2 standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

Table 33: **LVCMOS2 Voltage Specifications**

Parameter	Min	Typ	Max
V_{CCO}	2.3	2.5	2.7
V_{REF}	-	-	-
V_{TT}	-	-	-
V_{IH}	1.7	-	5.5
V_{IL}	–0.5	-	0.7
V_{OH}	1.9	-	-
V_{OL}	-	-	0.4
I_{OH} at V_{OH} (mA)	–12	-	-
I_{OL} at V_{OL} (mA)	12	-	-

AGP-2X

The specification for the AGP-2X standard does not document a recommended termination technique. DC voltage specifications appear in Table 34 for the AGP-2X standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

Table 34: **AGP-2X Voltage Specifications**

Parameter	Min	Typ	Max
V_{CCO}	3.0	3.3	3.6
$V_{REF} = N \times V_{CCO}$ (1)	1.17	1.32	1.48
V_{TT}	-	-	-
$V_{IH} \geq V_{REF} + 0.2$	1.37	1.52	-
$V_{IL} \leq V_{REF} - 0.2$	-	1.12	1.28
$V_{OH} \geq 0.9 \times V_{CCO}$	2.7	3.0	-
$V_{OL} \leq 0.1 \times V_{CCO}$	-	0.33	0.36
I_{OH} at V_{OH} (mA)	Note 2	-	-
I_{OL} at V_{OL} (mA)	Note 2	-	-

Notes:
1. N must be greater than or equal to 0.39 and less than or equal to 0.41.
2. Tested according to the relevant specification.

For design examples and more information on using the I/O, see XAPP179, *Using SelectIO Interfaces in Spartan-II and Spartan-IIE FPGAs*.

IOB Input Delay Adjustments for Different Standards(1)

Input delays associated with the pad are specified for LVTTL. For other standards, adjust the delays by the values shown. A delay adjusted in this way constitutes a worst-case limit.

Symbol	Description	Standard	Speed Grade		Units
			-6	-5	
Data Input Delay Adjustments					
T_{ILVTTL}	Standard-specific data input delay adjustments	LVTTL	0	0	ns
$T_{ILVCMOS2}$		LVCMOS2	–0.04	–0.05	ns
T_{IPCI33_3}		PCI, 33 MHz, 3.3V	–0.11	–0.13	ns
T_{IPCI33_5}		PCI, 33 MHz, 5.0V	0.26	0.30	ns
T_{IPCI66_3}		PCI, 66 MHz, 3.3V	–0.11	–0.13	ns
T_{IGTL}		GTL	0.20	0.24	ns
T_{IGTLP}		GTL+	0.11	0.13	ns
T_{IHSTL}		HSTL	0.03	0.04	ns
T_{ISSTL2}		SSTL2	–0.08	–0.09	ns
T_{ISSTL3}		SSTL3	–0.04	–0.05	ns
T_{ICTT}		CTT	0.02	0.02	ns
T_{IAGP}		AGP	–0.06	–0.07	ns

Notes:
1. Input timing for LVTTL is measured at 1.4V. For other I/O standards, see the table "Delay Measurement Methodology," page 60.

Calculation of T_{IOOP} as a Function of Capacitance

T_{IOOP} is the propagation delay from the O Input of the IOB to the pad. The values for T_{IOOP} are based on the standard capacitive load (C_{SL}) for each I/O standard as listed in the table "Constants for Calculating TIOOP", below.

For other capacitive loads, use the formulas below to calculate an adjusted propagation delay, T_{IOOP1}.

$$T_{IOOP1} = T_{IOOP} + Adj + (C_{LOAD} - C_{SL}) * F_L$$

Where:

- Adj is selected from "IOB Output Delay Adjustments for Different Standards", page 59, according to the I/O standard used
- C_{LOAD} is the capacitive load for the design
- F_L is the capacitance scaling factor

Delay Measurement Methodology

Standard	V_L (1)	V_H (1)	Meas. Point	V_{REF} Typ (2)
LVTTL	0	3	1.4	-
LVCMOS2	0	2.5	1.125	-
PCI33_5	Per PCI Spec			-
PCI33_3	Per PCI Spec			-
PCI66_3	Per PCI Spec			-
GTL	V_{REF} – 0.2	V_{REF} + 0.2	V_{REF}	0.80
GTL+	V_{REF} – 0.2	V_{REF} + 0.2	V_{REF}	1.0
HSTL Class I	V_{REF} – 0.5	V_{REF} + 0.5	V_{REF}	0.75
HSTL Class III	V_{REF} – 0.5	V_{REF} + 0.5	V_{REF}	0.90
HSTL Class IV	V_{REF} – 0.5	V_{REF} + 0.5	V_{REF}	0.90
SSTL3 I and II	V_{REF} – 1.0	V_{REF} + 1.0	V_{REF}	1.5
SSTL2 I and II	V_{REF} – 0.75	V_{REF} + 0.75	V_{REF}	1.25
CTT	V_{REF} – 0.2	V_{REF} + 0.2	V_{REF}	1.5
AGP	V_{REF} – (0.2xV_{CCO})	V_{REF} + (0.2xV_{CCO})	V_{REF}	Per AGP Spec

Notes:
1. Input waveform switches between V_L and V_H.
2. Measurements are made at V_{REF} Typ, Maximum, and Minimum. Worst-case values are reported.
3. I/O parameter measurements are made with the capacitance values shown in the table, "Constants for Calculating TIOOP". See Xilinx application note XAPP179 for the appropriate terminations.
4. I/O standard measurements are reflected in the IBIS model information except where the IBIS format precludes it.

Constants for Calculating T_{IOOP}

Standard	C_{SL} (1) (pF)	F_L (ns/pF)
LVTTL Fast Slew Rate, 2 mA drive	35	0.41
LVTTL Fast Slew Rate, 4 mA drive	35	0.20
LVTTL Fast Slew Rate, 6 mA drive	35	0.13
LVTTL Fast Slew Rate, 8 mA drive	35	0.079
LVTTL Fast Slew Rate, 12 mA drive	35	0.044
LVTTL Fast Slew Rate, 16 mA drive	35	0.043
LVTTL Fast Slew Rate, 24 mA drive	35	0.033
LVTTL Slow Slew Rate, 2 mA drive	35	0.41
LVTTL Slow Slew Rate, 4 mA drive	35	0.20
LVTTL Slow Slew Rate, 6 mA drive	35	0.100
LVTTL Slow Slew Rate, 8 mA drive	35	0.086
LVTTL Slow Slew Rate, 12 mA drive	35	0.058
LVTTL Slow Slew Rate, 16 mA drive	35	0.050
LVTTL Slow Slew Rate, 24 mA drive	35	0.048
LVCMOS2	35	0.041
PCI 33 MHz 5V	50	0.050
PCI 33 MHZ 3.3V	10	0.050
PCI 66 MHz 3.3V	10	0.033
GTL	0	0.014
GTL+	0	0.017
HSTL Class I	20	0.022
HSTL Class III	20	0.016
HSTL Class IV	20	0.014
SSTL2 Class I	30	0.028
SSTL2 Class II	30	0.016
SSTL3 Class I	30	0.029
SSTL3 Class II	30	0.016
CTT	20	0.035
AGP	10	0.037

Notes:
1. I/O parameter measurements are made with the capacitance values shown above. See Xilinx application note XAPP179 for the appropriate terminations.
2. I/O standard measurements are reflected in the IBIS model information except where the IBIS format precludes it.

DLL Timing Parameters

All devices are 100 percent functionally tested. Because of the difficulty in directly measuring many internal timing parameters, those parameters are derived from benchmark timing patterns. The following guidelines reflect worst-case values across the recommended operating conditions.

Symbol	Description	Speed Grade				Units
		-6		-5		
		Min	Max	Min	Max	
$F_{CLKINHF}$	Input clock frequency (CLKDLLHF)	60	200	60	180	MHz
$F_{CLKINLF}$	Input clock frequency (CLKDLL)	25	100	25	90	MHz
$T_{DLLPWHF}$	Input clock pulse width (CLKDLLHF)	2.0	-	2.4	-	ns
$T_{DLLPWLF}$	Input clock pulse width (CLKDLL)	2.5	-	3.0	-	ns

DLL Clock Tolerance, Jitter, and Phase Information

All DLL output jitter and phase specifications were determined through statistical measurement at the package pins using a clock mirror configuration and matched drivers.

Figure 52, page 63, provides definitions for various parameters in the table below.

Symbol	Description	F_{CLKIN}	CLKDLLHF		CLKDLL		Units
			Min	Max	Min	Max	
T_{IPTOL}	Input clock period tolerance		-	1.0	-	1.0	ns
T_{IJITCC}	Input clock jitter tolerance (cycle-to-cycle)		-	±150	-	±300	ps
T_{LOCK}	Time required for DLL to acquire lock	> 60 MHz	-	20	-	20	µs
		50-60 MHz	-	-	-	25	µs
		40-50 MHz	-	-	-	50	µs
		30-40 MHz	-	-	-	90	µs
		25-30 MHz	-	-	-	120	µs
T_{OJITCC}	Output jitter (cycle-to-cycle) for any DLL clock output(1)		-	±60	-	±60	ps
T_{PHIO}	Phase offset between CLKIN and CLKO(2)		-	±100	-	±100	ps
T_{PHOO}	Phase offset between clock outputs on the DLL(3)		-	±140	-	±140	ps
T_{PHIOM}	Maximum phase difference between CLKIN and CLKO(4)		-	±160	-	±160	ps
T_{PHOOM}	Maximum phase difference between clock outputs on the DLL(5)		-	±200	-	±200	ps

Notes:

1. **Output Jitter** is cycle-to-cycle jitter measured on the DLL output clock, *excluding* input clock jitter.
2. **Phase Offset between CLKIN and CLKO** is the worst-case fixed time difference between rising edges of CLKIN and CLKO, *excluding* output jitter and input clock jitter.
3. **Phase Offset between Clock Outputs on the DLL** is the worst-case fixed time difference between rising edges of any two DLL outputs, *excluding* Output Jitter and input clock jitter.
4. **Maximum Phase Difference between CLKIN an CLKO** is the sum of Output Jitter and Phase Offset between CLKIN and CLKO, or the greatest difference between CLKIN and CLKO rising edges due to DLL alone (*excluding* input clock jitter).
5. **Maximum Phase Difference between Clock Outputs on the DLL** is the sum of Output JItter and Phase Offset between any DLL clock outputs, or the greatest difference between any two DLL output rising edges due to DLL alone (*excluding* input clock jitter).

CLB Arithmetic Switching Characteristics

Setup times not listed explicitly can be approximated by decreasing the combinatorial delays by the setup time adjustment listed. Precise values are provided by the timing analyzer.

Symbol	Description	Speed Grade				Units
		-6		-5		
		Min	Max	Min	Max	
Combinatorial Delays						
T_{OPX}	F operand inputs to X via XOR	-	0.8	-	0.9	ns
T_{OPXB}	F operand input to XB output	-	1.3	-	1.5	ns
T_{OPY}	F operand input to Y via XOR	-	1.7	-	2.0	ns
T_{OPYB}	F operand input to YB output	-	1.7	-	2.0	ns
T_{OPCYF}	F operand input to COUT output	-	1.3	-	1.5	ns
T_{OPGY}	G operand inputs to Y via XOR	-	0.9	-	1.1	ns
T_{OPGYB}	G operand input to YB output	-	1.6	-	2.0	ns
T_{OPCYG}	G operand input to COUT output	-	1.2	-	1.4	ns
T_{BXCY}	BX initialization input to COUT	-	0.9	-	1.0	ns
T_{CINX}	CIN input to X output via XOR	-	0.4	-	0.5	ns
T_{CINXB}	CIN input to XB	-	0.1	-	0.1	ns
T_{CINY}	CIN input to Y via XOR	-	0.5	-	0.6	ns
T_{CINYB}	CIN input to YB	-	0.6	-	0.7	ns
T_{BYP}	CIN input to COUT output	-	0.1	-	0.1	ns
Multiplier Operation						
T_{FANDXB}	F1/2 operand inputs to XB output via AND	-	0.5	-	0.5	ns
T_{FANDYB}	F1/2 operand inputs to YB output via AND	-	0.9	-	1.1	ns
T_{FANDCY}	F1/2 operand inputs to COUT output via AND	-	0.5	-	0.6	ns
T_{GANDYB}	G1/2 operand inputs to YB output via AND	-	0.6	-	0.7	ns
T_{GANDCY}	G1/2 operand inputs to COUT output via AND	-	0.2	-	0.2	ns
Setup/Hold Times with Respect to Clock CLK(1)						
T_{CCKX} / T_{CKCX}	CIN input to FFX	1.1 / 0	-	1.2 / 0	-	ns
T_{CCKY} / T_{CKCY}	CIN input to FFY	1.2 / 0	-	1.3 / 0	-	ns

Notes:
1. A zero hold time listing indicates no hold time or a negative hold time.

Introduction

This section describes how the various pins on a Spartan®-II FPGA connect within the supported component packages, and provides device-specific thermal characteristics. Spartan-II FPGAs are available in both standard and Pb-free, RoHS versions of each package, with the Pb-free version adding a “G” to the middle of the package code. Except for the thermal characteristics, all information for the standard package applies equally to the Pb-free package.

Pin Types

Most pins on a Spartan-II FPGA are general-purpose, user-defined I/O pins. There are, however, different functional types of pins on Spartan-II FPGA packages, as outlined in Table 35.

Table 35: **Pin Definitions**

Pin Name	Dedicated	Direction	Description
GCK0, GCK1, GCK2, GCK3	No	Input	Clock input pins that connect to Global Clock Buffers. These pins become user inputs when not needed for clocks.
M0, M1, M2	Yes	Input	Mode pins are used to specify the configuration mode.
CCLK	Yes	Input or Output	The configuration Clock I/O pin. It is an input for slave-parallel and slave-serial modes, and output in master-serial mode.
$\overline{\text{PROGRAM}}$	Yes	Input	Initiates a configuration sequence when asserted Low.
DONE	Yes	Bidirectional	Indicates that configuration loading is complete, and that the start-up sequence is in progress. The output may be open drain.
$\overline{\text{INIT}}$	No	Bidirectional (Open-drain)	When Low, indicates that the configuration memory is being cleared. This pin becomes a user I/O after configuration.
BUSY/DOUT	No	Output	In Slave Parallel mode, BUSY controls the rate at which configuration data is loaded. This pin becomes a user I/O after configuration unless the Slave Parallel port is retained. In serial modes, DOUT provides configuration data to downstream devices in a daisy-chain. This pin becomes a user I/O after configuration.
D0/DIN, D1, D2, D3, D4, D5, D6, D7	No	Input or Output	In Slave Parallel mode, D0-D7 are configuration data input pins. During readback, D0-D7 are output pins. These pins become user I/Os after configuration unless the Slave Parallel port is retained. In serial modes, DIN is the single data input. This pin becomes a user I/O after configuration.
$\overline{\text{WRITE}}$	No	Input	In Slave Parallel mode, the active-low Write Enable signal. This pin becomes a user I/O after configuration unless the Slave Parallel port is retained.
$\overline{\text{CS}}$	No	Input	In Slave Parallel mode, the active-low Chip Select signal. This pin becomes a user I/O after configuration unless the Slave Parallel port is retained.
TDI, TDO, TMS, TCK	Yes	Mixed	Boundary Scan Test Access Port pins (IEEE 1149.1).
V_{CCINT}	Yes	Input	Power supply pins for the internal core logic.
V_{CCO}	Yes	Input	Power supply pins for output drivers (subject to banking rules)
V_{REF}	No	Input	Input threshold voltage pins. Become user I/Os when an external threshold voltage is not needed (subject to banking rules).
GND	Yes	Input	Ground.
IRDY, TRDY	No	See PCI core documentation	These signals can only be accessed when using Xilinx® PCI cores. If the cores are not used, these pins are available as user I/Os.

Table 36: **Spartan-II Family Package Options**

Package	Leads	Type	Maximum I/O	Lead Pitch (mm)	Footprint Area (mm)	Height (mm)	Mass[1] (g)
VQ100 / VQG100	100	Very Thin Quad Flat Pack (VQFP)	60	0.5	16 x 16	1.20	0.6
TQ144 / TQG144	144	Thin Quad Flat Pack (TQFP)	92	0.5	22 x 22	1.60	1.4
CS144 / CSG144	144	Chip Scale Ball Grid Array (CSBGA)	92	0.8	12 x 12	1.20	0.3
PQ208 / PQG208	208	Plastic Quad Flat Pack (PQFP)	140	0.5	30.6 x 30.6	3.70	5.3
FG256 / FGG256	256	Fine-pitch Ball Grid Array (FBGA)	176	1.0	17 x 17	2.00	0.9
FG456 / FGG456	456	Fine-pitch Ball Grid Array (FBGA)	284	1.0	23 x 23	2.60	2.2

Notes:

1. Package mass is ±10%.

Note: Some early versions of Spartan-II devices, including the XC2S15 and XC2S30 ES devices and the XC2S150 with date code 0045 or earlier, included a power-down pin. For more information, see Answer Record 10500.

VCCO Banks

Some of the I/O standards require specific V_{CCO} voltages. These voltages are externally connected to device pins that serve groups of IOBs, called banks. Eight I/O banks result from separating each edge of the FPGA into two banks (see Figure 3 in Module 2). Each bank has multiple V_{CCO} pins which must be connected to the same voltage. In the smaller packages, the V_{CCO} pins are connected between banks, effectively reducing the number of independent banks available (see Table 37). These interconnected banks are shown in the Pinout Tables with V_{CCO} pads for multiple banks connected to the same pin.

Table 37: **Independent VCCO Banks Available**

Package	VQ100 PQ208	CS144 TQ144	FG256 FG456
Independent Banks	1	4	8

Package Overview

Table 36 shows the six low-cost, space-saving production package styles for the Spartan-II family.

Each package style is available in an environmentally friendly lead-free (Pb-free) option. The Pb-free packages include an extra ‘G’ in the package style name. For example, the standard “CS144” package becomes “CSG144” when ordered as the Pb-free option. Leaded (non-Pb-free) packages may be available for selected devices, with the same pin-out and without the "G" in the ordering code; contact Xilinx sales for more information. The mechanical dimensions of the standard and Pb-free packages are similar, as shown in the mechanical drawings provided in Table 38.

For additional package information, see UG112: *Device Package User Guide*.

Mechanical Drawings

Detailed mechanical drawings for each package type are available from the Xilinx web site at the specified location in Table 38.

Material Declaration Data Sheets (MDDS) are also available on the Xilinx web site for each package.

Table 38: **Xilinx Package Documentation**

Package	Drawing	MDDS
VQ100	Package Drawing	PK173_VQ100
VQG100		PK130_VQG100
TQ144	Package Drawing	PK169_TQ144
TQG144		PK126_TQG144
CS144	Package Drawing	PK149_CS144
CSG144		PK103_CSG144
PQ208	Package Drawing	PK166_PQ208
PQG208		PK123_PQG208
FG256	Package Drawing	PK151_FG256
FGG256		PK105_FGG256
FG456	Package Drawing	PK154_FG456
FGG456		PK109_FGG456

XC2S30 Device Pinouts *(Continued)*

XC2S30 Pad Name						
Function	Bank	VQ100	TQ144	CS144	PQ208	Bndry Scan
I/O	4	-	-	-	P87	295
I/O	4	-	-	-	P88	298
I/O	4	-	P84	K8	P89	301
I/O	4	-	P83	N9	P90	304
V_{CCINT}	-	P42	P82	M9	P91	-
V_{CCO}	4	-	-	-	P92	-
GND	-	-	P81	L9	P93	-
I/O	4	P43	P80	K9	P94	307
I/O	4	P44	P79	N10	P95	310
I/O	4	-	P78	M10	P96	313
I/O, V_{REF}	4	P45	P77	L10	P98	316
I/O	4	-	-	-	P99	319
I/O	4	-	P76	N11	P100	322
I/O	4	P46	P75	M11	P101	325
I/O	4	P47	P74	L11	P102	328
GND	-	P48	P73	N12	P103	-
DONE	3	P49	P72	M12	P104	331
V_{CCO}	4	P50	P71	N13	P105	-
V_{CCO}	3	P50	P70	M13	P105	-
$\overline{PROGRAM}$	-	P51	P69	L12	P106	334
I/O ($\overline{INIT}$)	3	P52	P68	L13	P107	335
I/O (D7)	3	P53	P67	K10	P108	338
I/O	3	-	P66	K11	P109	341
I/O	3	-	-	-	P110	344
I/O, V_{REF}	3	P54	P65	K12	P111	347
I/O	3	-	P64	K13	P113	350
I/O	3	P55	P63	J10	P114	353
I/O (D6)	3	P56	P62	J11	P115	356
GND	-	-	P61	J12	P116	-
V_{CCO}	3	-	-	-	P117	-
I/O (D5)	3	P57	P60	J13	P119	359
I/O	3	P58	P59	H10	P120	362
I/O	3	-	-	-	P121	365
I/O	3	-	-	-	P122	368
I/O	3	-	-	-	P123	371
GND	-	-	-	-	P124	-
I/O, V_{REF}	3	P59	P58	H11	P125	374
I/O (D4)	3	P60	P57	H12	P126	377
I/O	3	-	P56	H13	P127	380
V_{CCINT}	-	P61	P55	G12	P128	-
I/O, TRDY(1)	3	P62	P54	G13	P129	386

XC2S30 Device Pinouts *(Continued)*

XC2S30 Pad Name						
Function	Bank	VQ100	TQ144	CS144	PQ208	Bndry Scan
V_{CCO}	3	P63	P53	G11	P130	-
V_{CCO}	2	P63	P53	G11	P130	-
GND	-	P64	P52	G10	P131	-
I/O, IRDY(1)	2	P65	P51	F13	P132	389
I/O	2	-	-	-	P133	392
I/O	2	-	P50	F12	P134	395
I/O (D3)	2	P66	P49	F11	P135	398
I/O, V_{REF}	2	P67	P48	F10	P136	401
GND	-	-	-	-	P137	-
I/O	2	-	-	-	P138	404
I/O	2	-	-	-	P139	407
I/O	2	-	-	-	P140	410
I/O	2	P68	P47	E13	P141	413
I/O (D2)	2	P69	P46	E12	P142	416
V_{CCO}	2	-	-	-	P144	-
GND	-	-	P45	E11	P145	-
I/O (D1)	2	P70	P44	E10	P146	419
I/O	2	P71	P43	D13	P147	422
I/O	2	-	P42	D12	P148	425
I/O, V_{REF}	2	P72	P41	D11	P150	428
I/O	2	-	-	-	P151	431
I/O	2	-	P40	C13	P152	434
I/O (DIN, D0)	2	P73	P39	C12	P153	437
I/O (DOUT, BUSY)	2	P74	P38	C11	P154	440
CCLK	2	P75	P37	B13	P155	443
V_{CCO}	2	P76	P36	B12	P156	-
V_{CCO}	1	P76	P35	A13	P156	-
TDO	2	P77	P34	A12	P157	-
GND	-	P78	P33	B11	P158	-
TDI	-	P79	P32	A11	P159	-
I/O ($\overline{CS}$)	1	P80	P31	D10	P160	0
I/O ($\overline{WRITE}$)	1	P81	P30	C10	P161	3
I/O	1	-	P29	B10	P162	6
I/O	1	-	-	-	P163	9
I/O, V_{REF}	1	P82	P28	A10	P164	12
I/O	1	-	-	-	P166	15
I/O	1	P83	P27	D9	P167	18
I/O	1	P84	P26	C9	P168	21
GND	-	-	P25	B9	P169	-
V_{CCO}	1	-	-	-	P170	-

XC2S50 Device Pinouts *(Continued)*

XC2S50 Pad Name		TQ144	PQ208	FG256	Bndry Scan
Function	Bank				
I/O	5	P99	P63	P6	326
GND	-	P98	P64	GND*	-
V_{CCO}	5	-	P65	V_{CCO} Bank 5*	-
V_{CCINT}	-	P97	P66	V_{CCINT}*	-
I/O	5	P96	P67	R6	329
I/O	5	P95	P68	M7	332
I/O	5	-	P69	N7	338
I/O	5	-	P70	T6	341
I/O	5	-	P71	P7	344
GND	-	-	P72	GND*	-
I/O, V_{REF}	5	P94	P73	P8	347
I/O	5	-	P74	R7	350
I/O	5	-	-	T7	353
I/O	5	P93	P75	T8	356
V_{CCINT}	-	P92	P76	V_{CCINT}*	-
I, GCK1	5	P91	P77	R8	365
V_{CCO}	5	P90	P78	V_{CCO} Bank 5*	-
V_{CCO}	4	P90	P78	V_{CCO} Bank 4*	-
GND	-	P89	P79	GND*	-
I, GCK0	4	P88	P80	N8	366
I/O	4	P87	P81	N9	370
I/O	4	P86	P82	R9	373
I/O	4	-	-	N10	376
I/O	4	-	P83	T9	379
I/O, V_{REF}	4	P85	P84	P9	382
GND	-	-	P85	GND*	-
I/O	4	-	P86	M10	385
I/O	4	-	P87	R10	388
I/O	4	-	P88	P10	391
I/O	4	P84	P89	T10	397
I/O	4	P83	P90	R11	400
V_{CCINT}	-	P82	P91	V_{CCINT}*	-
V_{CCO}	4	-	P92	V_{CCO} Bank 4*	-
GND	-	P81	P93	GND*	-
I/O	4	P80	P94	M11	403
I/O	4	P79	P95	T11	406
I/O	4	P78	P96	N11	409
I/O	4	-	-	R12	412

XC2S50 Device Pinouts *(Continued)*

XC2S50 Pad Name		TQ144	PQ208	FG256	Bndry Scan
Function	Bank				
I/O	4	-	P97	P11	415
I/O, V_{REF}	4	P77	P98	T12	418
GND	-	-	-	GND*	-
I/O	4	-	P99	T13	421
I/O	4	-	-	N12	424
I/O	4	P76	P100	R13	427
I/O	4	-	-	P12	430
I/O	4	P75	P101	P13	433
I/O	4	P74	P102	T14	436
GND	-	P73	P103	GND*	-
DONE	3	P72	P104	R14	439
V_{CCO}	4	P71	P105	V_{CCO} Bank 4*	-
V_{CCO}	3	P70	P105	V_{CCO} Bank 3*	-
$\overline{PROGRAM}$	-	P69	P106	P15	442
I/O ($\overline{INIT}$)	3	P68	P107	N15	443
I/O (D7)	3	P67	P108	N14	446
I/O	3	-	-	T15	449
I/O	3	P66	P109	M13	452
I/O	3	-	-	R16	455
I/O	3	-	P110	M14	458
GND	-	-	-	GND*	-
I/O, V_{REF}	3	P65	P111	L14	461
I/O	3	-	P112	M15	464
I/O	3	-	-	L12	467
I/O	3	P64	P113	P16	470
I/O	3	P63	P114	L13	473
I/O (D6)	3	P62	P115	N16	476
GND	-	P61	P116	GND*	-
V_{CCO}	3	-	P117	V_{CCO} Bank 3*	-
V_{CCINT}	-	-	P118	V_{CCINT}*	-
I/O (D5)	3	P60	P119	M16	479
I/O	3	P59	P120	K14	482
I/O	3	-	-	L16	485
I/O	3	-	P121	K13	488
I/O	3	-	P122	L15	491
I/O	3	-	P123	K12	494
GND	-	-	P124	GND*	-
I/O, V_{REF}	3	P58	P125	K16	497
I/O (D4)	3	P57	P126	J16	500

XC2S100 Device Pinouts *(Continued)*

XC2S100 Pad Name		TQ144	PQ208	FG256	FG456	Bndry Scan
Function	Bank					
V_{CCINT}	-	-	P38	V_{CCINT}*	V_{CCINT}*	-
V_{CCO}	6	-	P39	V_{CCO} Bank 6*	V_{CCO} Bank 6*	-
GND	-	P119	P40	GND*	GND*	-
I/O	6	P118	P41	K4	T1	314
I/O, V_{REF}	6	P117	P42	M1	R4	317
I/O	6	-	-	-	T2	320
I/O	6	P116	P43	L4	U1	323
I/O	6	-	-	M2	R5	326
I/O	6	-	P44	L3	U2	332
I/O, V_{REF}	6	P115	P45	N1	T3	335
V_{CCO}	6	-	-	V_{CCO} Bank 6*	V_{CCO} Bank 6*	-
GND	-	-	-	GND*	GND*	-
I/O	6	-	P46	P1	T4	338
I/O	6	-	-	L5	W1	341
I/O	6	-	-	-	U4	344
I/O	6	P114	P47	N2	Y1	347
I/O	6	-	-	M4	W2	350
I/O	6	P113	P48	R1	Y2	356
I/O	6	P112	P49	M3	W3	359
M1	-	P111	P50	P2	U5	362
GND	-	P110	P51	GND*	GND*	-
M0	-	P109	P52	N3	AB2	363
V_{CCO}	6	P108	P53	V_{CCO} Bank 6*	V_{CCO} Bank 6*	-
V_{CCO}	5	P107	P53	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
M2	-	P106	P54	R3	Y4	364
I/O	5	-	-	N5	V7	374
I/O	5	P103	P57	T2	Y6	377
I/O	5	-	-	-	AA4	380
I/O	5	-	-	P5	W6	383
I/O	5	-	P58	T3	Y7	386
GND	-	-	-	GND*	GND*	-
V_{CCO}	5	-	-	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
I/O, V_{REF}	5	P102	P59	T4	AA5	389
I/O	5	-	P60	M6	AB5	392
I/O	5	-	-	T5	AB6	398
I/O	5	P101	P61	N6	AA7	401
I/O	5	-	-	-	W7	404

XC2S100 Device Pinouts *(Continued)*

XC2S100 Pad Name		TQ144	PQ208	FG256	FG456	Bndry Scan
Function	Bank					
I/O, V_{REF}	5	P100	P62	R5	W8	407
I/O	5	P99	P63	P6	Y8	410
GND	-	P98	P64	GND*	GND*	-
V_{CCO}	5	-	P65	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
V_{CCINT}	-	P97	P66	V_{CCINT}*	V_{CCINT}*	-
I/O	5	P96	P67	R6	AA8	413
I/O	5	P95	P68	M7	V9	416
I/O	5	-	-	-	AB9	419
I/O	5	-	P69	N7	Y9	422
I/O	5	-	P70	T6	W10	428
I/O	5	-	P71	P7	AB10	431
GND	-	-	P72	GND*	GND*	-
I/O, V_{REF}	5	P94	P73	P8	Y10	434
I/O	5	-	P74	R7	V11	437
I/O	5	-	-	T7	W11	440
I/O	5	P93	P75	T8	AB11	443
V_{CCINT}	-	P92	P76	V_{CCINT}*	V_{CCINT}*	-
I, GCK1	5	P91	P77	R8	Y11	455
V_{CCO}	5	P90	P78	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
V_{CCO}	4	P90	P78	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	P89	P79	GND*	GND*	-
I, GCK0	4	P88	P80	N8	W12	456
I/O	4	P87	P81	N9	U12	460
I/O	4	P86	P82	R9	Y12	466
I/O	4	-	-	N10	AA12	469
I/O	4	-	P83	T9	AB13	472
I/O, V_{REF}	4	P85	P84	P9	AA13	475
GND	-	-	P85	GND*	GND*	-
I/O	4	-	P86	M10	Y13	478
I/O	4	-	P87	R10	V13	481
I/O	4	-	P88	P10	AA14	487
I/O	4	-	-	-	V14	490
I/O	4	P84	P89	T10	AB15	493
I/O	4	P83	P90	R11	AA15	496
V_{CCINT}	-	P82	P91	V_{CCINT}*	V_{CCINT}*	-
V_{CCO}	4	-	P92	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	P81	P93	GND*	GND*	-
I/O	4	P80	P94	M11	Y15	499

XC2S150 Device Pinouts *(Continued)*

XC2S150 Pad Name		PQ208	FG256	FG456	Bndry Scan
Function	Bank				
I/O	6	P46	P1	T4	404
I/O	6	-	L5	W1	407
I/O	6	-	-	V2	410
I/O	6	-	-	U4	413
I/O	6	P47	N2	Y1	416
GND	-	-	GND*	GND*	-
I/O	6	-	M4	W2	419
I/O	6	-	-	V3	422
I/O	6	-	-	V4	425
I/O	6	P48	R1	Y2	428
I/O	6	P49	M3	W3	431
M1	-	P50	P2	U5	434
GND	-	P51	GND*	GND*	-
M0	-	P52	N3	AB2	435
V_{CCO}	6	P53	V_{CCO} Bank 6*	V_{CCO} Bank 6*	-
V_{CCO}	5	P53	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
M2	-	P54	R3	Y4	436
I/O	5	-	-	W5	443
I/O	5	-	-	AB3	446
I/O	5	-	N5	V7	449
GND	-	-	GND*	GND*	-
I/O	5	P57	T2	Y6	452
I/O	5	-	-	AA4	455
I/O	5	-	-	AB4	458
I/O	5	-	P5	W6	461
I/O	5	P58	T3	Y7	464
GND	-	-	GND*	GND*	-
V_{CCO}	5	-	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
I/O, V_{REF}	5	P59	T4	AA5	467
I/O	5	P60	M6	AB5	470
I/O	5	-	-	V8	473
I/O	5	-	-	AA6	476
I/O	5	-	T5	AB6	479
I/O	5	P61	N6	AA7	482
I/O	5	-	-	W7	485
I/O, V_{REF}	5	P62	R5	W8	488
I/O	5	P63	P6	Y8	491
GND	-	P64	GND*	GND*	-

XC2S150 Device Pinouts *(Continued)*

XC2S150 Pad Name		PQ208	FG256	FG456	Bndry Scan
Function	Bank				
V_{CCO}	5	P65	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
V_{CCINT}	-	P66	V_{CCINT}*	V_{CCINT}*	-
I/O	5	P67	R6	AA8	494
I/O	5	P68	M7	V9	497
I/O	5	-	-	W9	503
I/O	5	-	-	AB9	506
I/O	5	P69	N7	Y9	509
I/O	5	-	-	V10	512
I/O	5	P70	T6	W10	518
I/O	5	P71	P7	AB10	521
GND	-	P72	GND*	GND*	-
V_{CCO}	5	-	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
I/O, V_{REF}	5	P73	P8	Y10	524
I/O	5	P74	R7	V11	527
I/O	5	-	T7	W11	530
I/O	5	P75	T8	AB11	533
I/O	5	-	-	U11	536
V_{CCINT}	-	P76	V_{CCINT}*	V_{CCINT}*	-
I, GCK1	5	P77	R8	Y11	545
V_{CCO}	5	P78	V_{CCO} Bank 5*	V_{CCO} Bank 5*	-
V_{CCO}	4	P78	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	P79	GND*	GND*	-
I, GCK0	4	P80	N8	W12	546
I/O	4	P81	N9	U12	550
I/O	4	-	-	V12	553
I/O	4	P82	R9	Y12	556
I/O	4	-	N10	AA12	559
I/O	4	P83	T9	AB13	562
I/O, V_{REF}	4	P84	P9	AA13	565
V_{CCO}	4	-	V_{CCO} Bank 4*	V_{CCO} Bank 4*	-
GND	-	P85	GND*	GND*	-
I/O	4	P86	M10	Y13	568
I/O	4	P87	R10	V13	571
I/O	4	-	-	W14	577
I/O	4	P88	P10	AA14	580
I/O	4	-	-	V14	583
I/O	4	-	-	Y14	586
I/O	4	P89	T10	AB15	592